M4841
High-Throughput Device Handler
for Volume Production Testing of MCUs and DSPs
Today’s semiconductors are gaining in complexity both in circuit design and packaging, and continue to be challenged by high-volume applications that function in environments with wide-ranging temperature fluctuations. Semiconductor test and handling equipment must evolve to meet these requirements, in the same way it must adapt to increasing demands for higher parallelism and higher throughput. Unique in its class, ADVANTEEST’s new M4841 Dynamic Test Handler enables high-throughput parallel test for very high volumes of devices and supports complex ICs and packages, including BGA, CSP and QFP. Because of its advanced performance capabilities and features, the M4841 is the optimal dynamic test handler for high volume production of devices used in consumer products such as portable digital equipment and automotive systems.

- Supports Test Across Wide Temperature Range
The M4841 maintains a constant temperature and devices can be cooled to -40°C or heated to 125°C. This wide temperature range ensures that the M4841 can be used to simulate device application environments with severe temperature ranges, such as those experienced in automotive or avionics. By minimizing the effects of heating or cooling upon throughput, the M4841 offers consistently high speeds and performance, even at extreme temperatures.

- Modular Structure
The M4841 is designed so that users can choose the best configuration for their needs; the number of devices for parallel test, test temperature range and throughput. Because of the variety of configurations available for the M4841, users can optimize the M4841 to not only meet their test needs but also optimize cost, for a very efficient as well as very high performing handler solution.

M4841 Major Specifications

<table>
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<tr>
<th>Target Packages:</th>
<th>BGA, CSP, QFP, etc.</th>
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<tr>
<td>Simultaneous Testing:</td>
<td>Up to 32 devices</td>
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<td>Throughput:</td>
<td>18,500 devices per hour</td>
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<tr>
<td>Temperature Range:</td>
<td>-40°C to +125°C (Option: -55°C to +155°C)</td>
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Please refer to product manual for complete system specifications. Specifications may change without notification.

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